International Rectifier

IRLML2502PbF

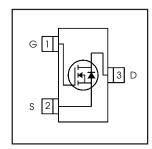
HEXFET® Power MOSFET

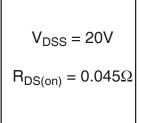
- Ultra Low On-Resistance
- N-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)
- Available in Tape and Reel
- Fast Switching
- Lead-Free

Description

These N-Channel MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in battery and load management.

A thermally enhanced large pad leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3™, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards. The thermal resistance and power dissipation are the best available.







Absolute Maximum Ratings

	Parameter	Max.	Units
V _{DS}	Drain- Source Voltage	20	V
$I_D @ T_A = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 4.5V	4.2	
I _D @ T _A = 70°C Continuous Drain Current, V _{GS} @ 4.5V		3.4	Α
I _{DM}	Pulsed Drain Current ①	33	
P _D @T _A = 25°C	Power Dissipation	1.25	W
P _D @T _A = 70°C	Power Dissipation	0.8	VV
	Linear Derating Factor	0.01	W/°C
V_{GS}	Gate-to-Source Voltage	± 12	V
T _{J,} T _{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient®	75	100	°C/W

Electrical Characteristics @ T₁ = 25°C (unless otherwise specified)

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Parameter	Min.	Тур.	Max.	Units	Conditions	
Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_D = 250\mu A$	
Breakdown Voltage Temp. Coefficient		0.01		V/°C	Reference to 25°C, I _D = 1mA	
Static Drain-to-Source On-Registance		0.035	0.045		V _{GS} = 4.5V, I _D = 4.2A ②	
Static Dialitio-Source Off-Hesistatice		0.050	0.080	52	V _{GS} = 2.5V, I _D = 3.6A ②	
Gate Threshold Voltage	0.60		1.2	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Forward Transconductance	5.8			S	$V_{DS} = 10V, I_D = 4.0A$	
Drain to Source Leakage Current			1.0		$V_{DS} = 16V, V_{GS} = 0V$	
Drain-to-Source Leakage Current			25	μΑ	V _{DS} = 16V, V _{GS} = 0V, T _J = 70°C	
Gate-to-Source Forward Leakage			-100	nΛ	V _{GS} = -12V	
Gate-to-Source Reverse Leakage			100	IIA	V _{GS} = 12V	
Total Gate Charge		8.0	12		$I_D = 4.0A$	
Gate-to-Source Charge		1.8	2.7	nC	$V_{DS} = 10V$	
Gate-to-Drain ("Miller") Charge		1.7	2.6		V _{GS} = 5.0V ②	
Turn-On Delay Time		7.5			$V_{DD} = 10V$	
Rise Time		10		ne	$I_D = 1.0A$	
Turn-Off Delay Time		54		115	$R_G = 6\Omega$	
Fall Time		26			$R_D = 10\Omega$ ②	
Input Capacitance		740			$V_{GS} = 0V$	
Output Capacitance		90		pF	$V_{DS} = 15V$	
Reverse Transfer Capacitance		66			f = 1.0MHz	
	Parameter Drain-to-Source Breakdown Voltage Breakdown Voltage Temp. Coefficient Static Drain-to-Source On-Resistance Gate Threshold Voltage Forward Transconductance Drain-to-Source Leakage Current Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage Total Gate Charge Gate-to-Drain ("Miller") Charge Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Input Capacitance Output Capacitance	Parameter Min. Drain-to-Source Breakdown Voltage 20 Breakdown Voltage Temp. Coefficient — Static Drain-to-Source On-Resistance — Gate Threshold Voltage 0.60 Forward Transconductance 5.8 Drain-to-Source Leakage Current — Gate-to-Source Forward Leakage — Gate-to-Source Reverse Leakage — Total Gate Charge — Gate-to-Drain ("Miller") Charge — Turn-On Delay Time — Rise Time — Turn-Off Delay Time — Fall Time — Input Capacitance — Output Capacitance —	Parameter Min. Typ. Drain-to-Source Breakdown Voltage 20 — Breakdown Voltage Temp. Coefficient — 0.01 Static Drain-to-Source On-Resistance — 0.050 Gate Threshold Voltage 0.60 — Forward Transconductance 5.8 — Drain-to-Source Leakage Current — — Gate-to-Source Forward Leakage — — Gate-to-Source Reverse Leakage — — Total Gate Charge — 8.0 Gate-to-Source Charge — 1.8 Gate-to-Drain ("Miller") Charge — 1.7 Turn-On Delay Time — 7.5 Rise Time — 10 Turn-Off Delay Time — 54 Fall Time — 26 Input Capacitance — 740 Output Capacitance — 90	Parameter Min. Typ. Max. Drain-to-Source Breakdown Voltage 20 — — — Breakdown Voltage Temp. Coefficient — 0.01 — Static Drain-to-Source On-Resistance — 0.035 0.045 — Gate Threshold Voltage 0.60 — 1.2 Forward Transconductance 5.8 — — Drain-to-Source Leakage Current — 1.0 — Gate-to-Source Forward Leakage — -100 Gate-to-Source Reverse Leakage — 100 Total Gate Charge — 8.0 12 Gate-to-Source Charge — 1.8 2.7 Gate-to-Drain ("Miller") Charge — 1.7 2.6 Turn-On Delay Time — 7.5 — Rise Time — 10 — Turn-Off Delay Time — 54 — Fall Time — 26 — Input Capacitance — 740 — Output Capacitance — 90 —	Parameter Min. Typ. Max. Units Drain-to-Source Breakdown Voltage 20 — — V Breakdown Voltage Temp. Coefficient — 0.01 — V°C Static Drain-to-Source On-Resistance — 0.035 0.045 — Ω Gate Threshold Voltage 0.60 — 1.2 V Forward Transconductance 5.8 — — S Drain-to-Source Leakage Current — 1.0 — μΑ Gate-to-Source Forward Leakage — — 1.0 — μΑ Gate-to-Source Reverse Leakage — — 100 — nA Total Gate Charge — 8.0 12 nC — nC Gate-to-Source Charge — 1.7 2.6 — nC — nC Gate-to-Drain ("Miller") Charge — 1.7 2.6 — ns ns ns ns ns ns ns ns	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			1.0		MOSFET symbol
	(Body Diode)			1.3	A	showing the
I _{SM}	Pulsed Source Current			33	1 ^	integral reverse
	(Body Diode) ①			33		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C$, $I_S = 1.3A$, $V_{GS} = 0V$ ②
t _{rr}	Reverse Recovery Time		16	24	ns	$T_J = 25^{\circ}C, I_F = 1.3A$
Q _{rr}	Reverse Recovery Charge		8.6	13	nC	di/dt = 100A/µs ②

Notes:

- $\ensuremath{\mathbb{O}}$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Pulse width \leq 300 μ s; duty cycle \leq 2%.

International TOR Rectifier

IRLML2502PbF

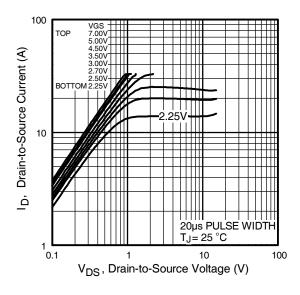


Fig 1. Typical Output Characteristics

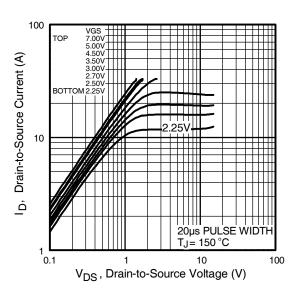


Fig 2. Typical Output Characteristics

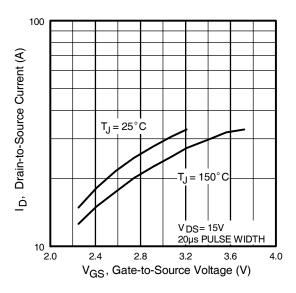


Fig 3. Typical Transfer Characteristics

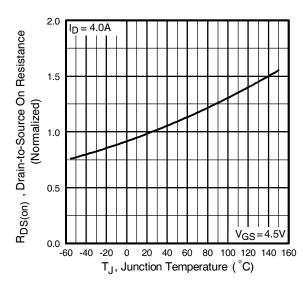


Fig 4. Normalized On-Resistance Vs. Temperature

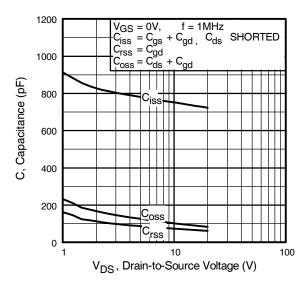


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

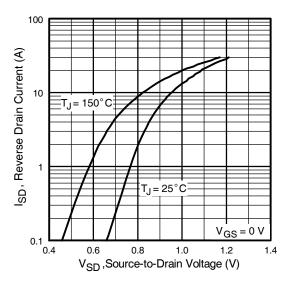


Fig 7. Typical Source-Drain Diode Forward Voltage

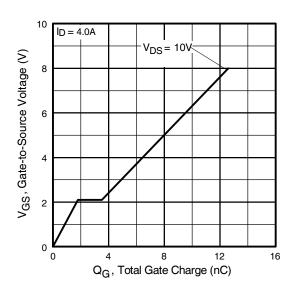


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

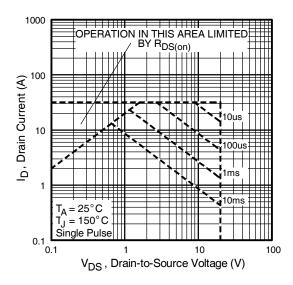


Fig 8. Maximum Safe Operating Area

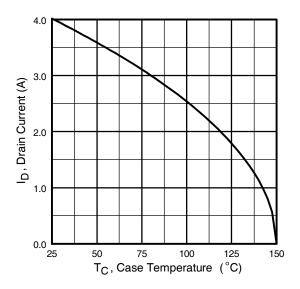


Fig 9. Maximum Drain Current Vs. Case Temperature

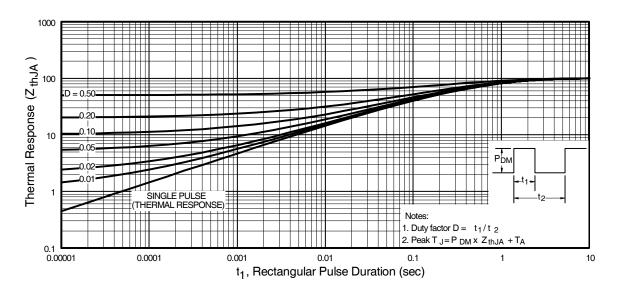


Fig 10. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

International

TOR Rectifier

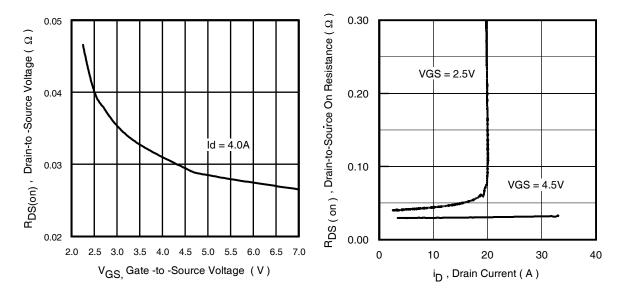


Fig 11. On-Resistance Vs. Gate Voltage

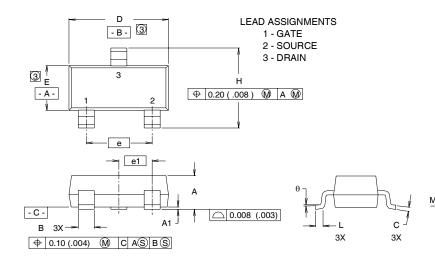
Fig 12. On-Resistance Vs. Drain Current

International TOR Rectifier

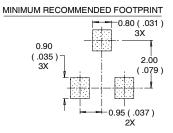
IRLML2502PbF

Micro3™ Package Outline

Dimensions are shown in millimeters (inches)



DIM	INC	HES	MILLIMETERS		
	MIN	MAX	MIN	MAX	
Α	.032	.044	0.82	1.11	
A1	.001	.004	0.02	0.10	
В	.015	.021	0.38	0.54	
С	.004	.006	0.10	0.15	
D	.105	.120	2.67	3.05	
е	.0750 BASIC		1.90 BASIC		
e1	.0375	BASIC	0.95 BASIC		
Е	.047	.055	1.20	1.40	
Н	.083	.098	2.10	2.50	
L	.005	.010	0.13	0.25	
θ	0°	8°	0°	8°	

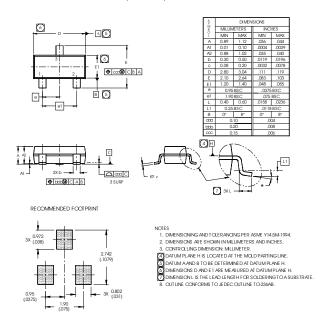


- NOTES:
 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.
 2. CONTROLLING DIMENSION: INCH.
 3 DIMENSIONS DO NOT INCLUDE MOLD FLASH.

International IOR Rectifier

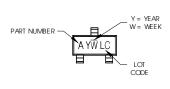
Micro3 (SOT-23) Package Outline

Dimensions are shown in millimeters (inches)



Micro3 (SOT-23/TO-236AB) Part Marking Information





PART NUMBER CODE REFERENCE:

A= IRLML2402

B = IRLML2803 C = IRLML6302

D = IRLML5103 E = IRLML6402

F = IRLML6401

G= IRLML2502 H = IRLML5203

Note: A line above the work week (as shown here) indicates Lead-Free.

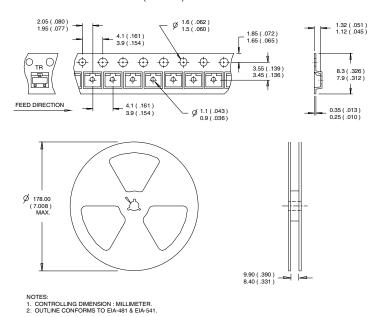
YEAR	Υ	WORK WEEK	W
2001	1	01	Α
2002	2	02	В
2003	3	03	С
1994	4	04	D
1995	5		
1996	6		
1997	7		
1998	8	1	1
1999	9	7	7
2000	0	24	X
		25	Υ
		26	Z

W= (27-52) IF PRECEDED BY ALETTER

YEAR	Υ	WORK WEEK	W
2001	Α	27	Α
2002	В	28	В
2003	С	29	С
1994	D	30	D
1995	E		
1996	F		
1997	G		
1998	Н	1	- 1
1999	J	7	1
2000	K	50	X
		51	Υ
		52	Z

Micro3™ Tape & Reel Information

Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice.



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